Description

The 9DML0441 / 9DML0451 devices are 3.3V members of IDT's Full-Featured PCIe family. They support PCIe Gen1-4 Common Clocked (CC), Separate Reference no Spread (SRnS), and Separate Reference Independent Spread (SRIS) architectures. The parts provide a choice of asynchronous and glitch-free switching modes, and offer a choice of integrated output terminations for direct connection to 85Ω or 100Ω transmission lines. The 9DML04P1 can be factory programmed with a user-defined power-up default configuration.

Typical Applications

Servers, ATCA, ATE, Storage, Master/Slave applications

Output Features

- Four 1–200MHz Low-Power HCSL (LP-HCSL) DIF pairs
  - 9DML0441 default ZOUT = 100Ω
  - 9DML0451 default ZOUT = 85Ω
  - 9DML04P1 factory programmable defaults
- See AN-891 for easy termination to other logic levels

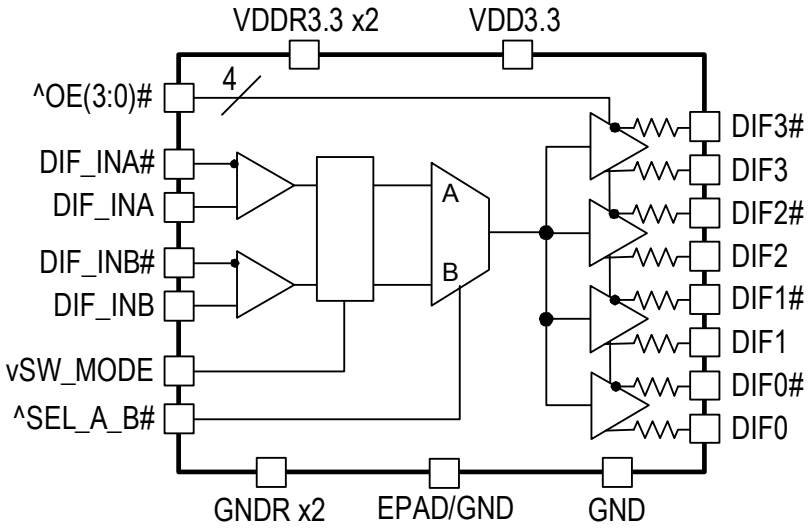
Features

- Direct connection to 100Ω (xx41) or 85Ω (xx51) transmission lines saves up to 16 resistors
- 79mW typical power consumption
- Spread Spectrum (SS) compatible
- Factory programmed P1 device allows exact optimization to customer requirements:
  - Control input polarity
  - Control input pull up/downs
  - Slew rate for each output
  - Differential output amplitude
  - Output impedance for each output
- OE# pins for each output
- HCSL-compatible differential inputs; can be driven by common clock source
- Selectable asynchronous or glitch-free switching; allows the mux to be selected at power-up even if both inputs are not running, then transition to glitch-free switching mode
- Space saving 4 × 4 mm 24-VFQFPN

Key Specifications

- PCIe Gen1–4 CC compliant
- PCIe Gen2–3 SRIS compliant
- Output-to-output skew < 50ps
- PCIe Gen4 additive phase jitter is < 0.1 ps rms
- 12kHz–20MHz additive phase jitter 285fs rms typical at156.25MHz

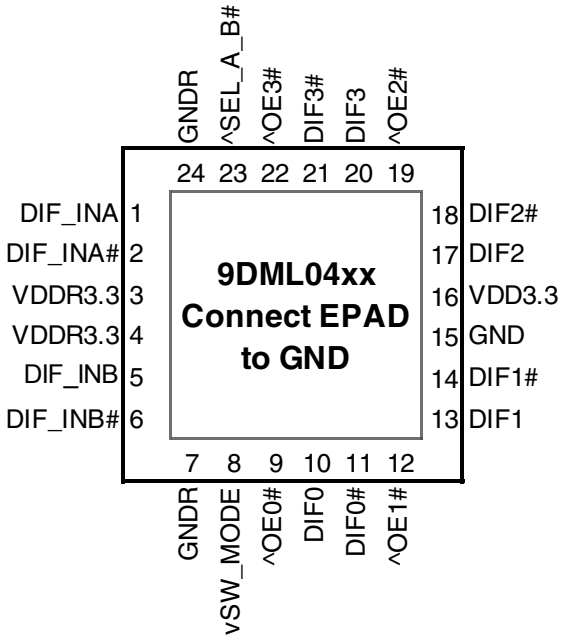
Block Diagram



Note: Resistors default to internal on xx41/xx51 devices. P1 devices have programmable default impedances on an output-by-output basis.

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Pin Configuration



24-VFQFPN, 4 x 4 mm, 0.5mm pitch

^ prefix indicates internal pull-up resistor

v prefix indicates internal pull-down resistor

Power Management Table

OEx# Pin	DIF_IN	DIFx	
		True O/P	Comp. O/P
0	Running	Running	Running
1	Running	Low	Low

Power Connections

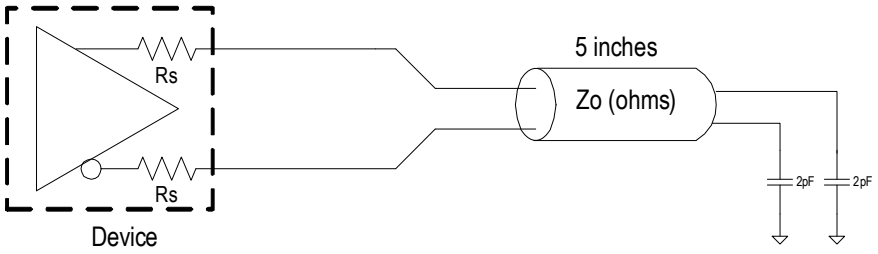
Pin Number		Description
VDD	GND	
3	24	Input A receiver analog
4	7	Input B receiver analog
16	15	DIF outputs

Pin Descriptions

Pin#	Pin Name	Type	Pin Description
1	DIF_INA	IN	HCSL Differential True input
2	DIF_INA#	IN	HCSL Differential Complement Input
3	VDDR3.3	PWR	3.3V power for differential input clock (receiver). This VDD should be treated as an Analog power rail and filtered appropriately.
4	VDDR3.3	PWR	3.3V power for differential input clock (receiver). This VDD should be treated as an Analog power rail and filtered appropriately.
5	DIF_INB	IN	HCSL Differential True input
6	DIF_INB#	IN	HCSL Differential Complement Input
7	GNDR	GND	Analog Ground pin for the differential input (receiver)
8	vSW_MODE	IN	Switch Mode. This pin selects either asynchronous or glitch-free switching of the mux. Use asynchronous mode if 0 or 1 of the input clocks is running. Use glitch-free mode if both input clocks are running. This pin has an internal pull down resistor of ~120kohms. 0 = asynchronous mode 1 = glitch-free mode
9	^OE0#	IN	Active low input for enabling DIF pair 0. This pin has an internal pull-up resistor. 1 =disable outputs, 0 = enable outputs
10	DIF0	OUT	Differential true clock output
11	DIF0#	OUT	Differential Complementary clock output
12	^OE1#	IN	Active low input for enabling DIF pair 1. This pin has an internal pull-up resistor. 1 =disable outputs, 0 = enable outputs
13	DIF1	OUT	Differential true clock output
14	DIF1#	OUT	Differential Complementary clock output
15	GND	GND	Ground pin.
16	VDD3.3	PWR	Power supply, nominal 3.3V
17	DIF2	OUT	Differential true clock output
18	DIF2#	OUT	Differential Complementary clock output
19	^OE2#	IN	Active low input for enabling DIF pair 2. This pin has an internal pull-up resistor. 1 =disable outputs, 0 = enable outputs
20	DIF3	OUT	Differential true clock output
21	DIF3#	OUT	Differential Complementary clock output
22	^OE3#	IN	Active low input for enabling DIF pair 3. This pin has an internal pull-up resistor. 1 =disable outputs, 0 = enable outputs
23	^SEL_A_B#	IN	Input to select differential input clock A or differential input clock B. This input has an internal pull-up resistor. 0 = Input B selected, 1 = Input A selected.
24	GNDR	GND	Analog Ground pin for the differential input (receiver)
25	EPAD	GND	Connect to Ground.

Test Loads

Low-Power HCSL Differential Output Test Load



Terminations

Device	Zo (Ω)	Rs (Ω)
9DML0441	100	None needed
9DML0451	100	7.5
9DML04P1	100	Prog.
9DML0441	85	N/A
9DML0451	85	None needed
9DML04P1	85	Prog.

Alternate Terminations

The 9DML family can easily drive LVPECL, LVDS, and CML logic. See "AN-891 Driving LVPECL, LVDS, and CML Logic with IDT's "Universal" Low-Power HCSL Outputs" for details.

Absolute Maximum Ratings

Stresses above the ratings listed below can cause permanent damage to the 9DML0441 / 9DML0451. These ratings, which are standard values for IDT commercially rated parts, are stress ratings only. Functional operation of the device at these or any other conditions above those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods can affect product reliability. Electrical parameters are guaranteed only over the recommended operating temperature range.

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Units	Notes
Supply Voltage	VDDx				4.6	V	1,2
Input Voltage	V_{IN}		-0.5		V_{DD}+0.5	V	1,3
Input High Voltage, SMBus	V_{IHSMB}	SMBus clock and data pins			3.9	V	1
Storage Temperature	Ts		-65		150	°C	1
Junction Temperature	Tj				125	°C	1
Input ESD protection	ESD prot	Human Body Model	2500			V	1

[1] Guaranteed by design and characterization, not 100% tested in production.

[2] Operation under these Conditions is neither implied nor guaranteed.

[3] Not to exceed 4.6V.

Electrical Characteristics–Clock Input Parameters

$T_A = T_{AMB}$, Supply Voltages per normal operation Conditions, See Test Loads for Loading Conditions

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Units	Notes
Input Common Mode Voltage - DIF_IN	V_{COM}	Common Mode Input Voltage	150		900	mV	1
Input Swing - DIF_IN	V_{SWING}	Differential value	300			mV	1
Input Slew Rate - DIF_IN	dv/dt	Measured differentially	0.4		8	V/ns	1,2
Input Leakage Current	I_{IN}	$V_{IN} = V_{DD}$, V_{IN} = GND	-5		5	uA	
Input Duty Cycle	d_{tin}	Measurement from differential waveform	45		55	%	1
Input Jitter - Cycle to Cycle	J_{DIFIn}	Differential Measurement	0		125	ps	1

[1] Guaranteed by design and characterization, not 100% tested in production.

[2] Slew rate measured through +/-75mV window centered around differential zero.

Electrical Characteristics–Current Consumption

$T_A = T_{AMB}$, Supply Voltages per normal operation Conditions, See Test Loads for Loading Conditions

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Units	Notes
Operating Supply Current	I_{DD}	VDD, All outputs active at 100MHz		24	31	mA	
Powerdown Current	I_{DDPD}	VDD, all outputs disabled		2	3	mA	1

[1] Input clock stopped.

Electrical Characteristics–Input/Supply/Common Parameters–Normal Operating Conditions

$T_A = T_{AMB}$, Supply Voltages per normal operation Conditions, See Test Loads for Loading Conditions

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Units	Notes
Supply Voltage	VDDx	Supply voltage for core and analog	3.135	3.3	3.465	V	
Ambient Operating Temperature	T_{AMB}	Industrial range	-40	25	85	°C	
Input High Voltage	V_{IH}	Single-ended inputs, except SMBus	0.75 V_{DD}		V_{DD} + 0.3	V	
Input Low Voltage	V_{IL}	Single-ended inputs, except SMBus	-0.3		0.25 V_{DD}	V	
Input Current	I_{IN}	Single-ended inputs, V_{IN} = GND, V_{IN} = VDD	-5		5	uA	
	I_{INP}	Single-ended inputs V_{IN} = 0 V; Inputs with internal pull-up resistors V_{IN} = VDD; Inputs with internal pull-down resistors	-50		50	uA	
Input Frequency	F_{ibyp}		1		200	MHz	2
Pin Inductance	L_{pin}				7	nH	1
Capacitance	C_{IN}	Logic Inputs, except DIF_IN	1.5		5	pF	1
	C_{INDIF_IN}	DIF_IN differential clock inputs	1.5		2.7	pF	1
	C_{OUT}	Output pin capacitance			6	pF	1
Clk Stabilization	T_{STAB}	From V_{DD} Power-Up and after input clock stabilization or de-assertion of PD# to 1st clock		0.74	1	ms	1,2
Input SS Modulation Frequency PCIe	$f_{MODINPCIe}$	Allowable Frequency for PCIe Applications (Triangular Modulation)	30	31.5	33	kHz	
Input SS Modulation Frequency non-PCIe	f_{MODIN}	Allowable Frequency for non-PCIe Applications (Triangular Modulation)	0		66	kHz	
OE# Latency	$t_{LATOE\#}$	DIF start after OE# assertion DIF stop after OE# deassertion	1	2	3	clocks	1,3
Tfall	t_F	Fall time of single-ended control inputs			5	ns	2
Trise	t_R	Rise time of single-ended control inputs			5	ns	2

[1] Guaranteed by design and characterization, not 100% tested in production.

[2] Control input must be monotonic from 20% to 80% of input swing.

[3] Time from deassertion until outputs are > 200 mV.

Electrical Characteristics–DIF Low-Power HCSL Outputs

$T_A = T_{AMB}$, Supply Voltages per normal operation Conditions, See Test Loads for Loading Conditions

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Units	Notes
Slew rate	dV/dt	Scope averaging on, default settings	1.5	2.4	4	V/ns	1, 2, 3
Slew rate matching	ΔdV/dt	Slew rate matching		8.1	20	%	1, 4
Voltage High	V_{HIGH}	Statistical measurement on single-ended signal using oscilloscope math function. (Scope averaging on)	660	783	850	mV	7
Voltage Low	V_{LOW}		-150	-24	150		7
Maximum Voltage	VMaximum	Measurement on single ended signal using absolute value. (Scope averaging off)		814	1150	mV	7
Minimum Voltage	VMinimum		-300	-66			7
Crossing Voltage (abs)	Vcross_abs	Scope averaging off	250	368	550	mV	1, 5
Crossing Voltage (var)	Δ-Vcross	Scope averaging off		17	140	mV	1, 6

[1] Guaranteed by design and characterization, not 100% tested in production.

[2] Measured from differential waveform

[3] Slew rate is measured through the Vswing voltage range centered around differential 0V. This results in a +/-150mV window around differential 0V. These are defaults for the 41/51 devices, alternate settings are available in the P1 device.

[4] Matching applies to rising edge rate for Clock and falling edge rate for Clock#. It is measured using a +/-75mV window centered on the average cross point where Clock rising meets Clock# falling. The median cross point is used to calculate the voltage thresholds the oscilloscope is to use for the edge rate calculations.

[5] Vcross is defined as voltage where Clock = Clock# measured on a component test board and only applies to the differential rising edge (i.e. Clock rising and Clock# falling).

[6] The total variation of all Vcross measurements in any particular system. Note that this is a subset of Vcross_Minimum/Maximum (Vcross absolute) allowed. The intent is to limit Vcross induced modulation by setting Δ-Vcross to be smaller than Vcross absolute.

[7] These are defaults for the 41/51 devices. They are factory adjustable in the P1 device.

Electrical Characteristics–Output Duty Cycle, Jitter, Skew and PLL Characteristics

$T_A = T_{AMB}$, Supply Voltages per normal operation Conditions, See Test Loads for Loading Conditions

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Units	Notes
Duty Cycle Distortion	t_{DCD}	Measured differentially, at 100MHz	0	0.2	0.7	%	1,3
Skew, Input to Output	t_{pd}	V_T = 50%	2637	3381	4273	ps	1
Skew, Output to Output	t_{sk3}	V_T = 50%		23	50	ps	1
Jitter, Cycle to cycle	$t_{jcyc-cyc}$	*Additive* Jitter in Bypass Mode			1	ps	1,2

[1] Guaranteed by design and characterization, not 100% tested in production.

[2] Measured from differential waveform.

[3] Duty cycle distortion is the difference in duty cycle between the output and the input clock.

Electrical Characteristics–Filtered Phase Jitter Parameters - PCIe Common Clocked (CC) Architectures

T_{AMB} = over the specified operating range. Supply Voltages per normal operation Conditions, See Test Loads for Loading Conditions

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Industry Limit	Units	Notes
Additive Phase Jitter	$t_{jphPCIeG1-CC}$	PCIe Gen 1		1.5	5	n/a	ps (p-p)	1,2,3,5
	$t_{jphPCIeG2-CC}$	PCIe Gen 2 Lo Band 10kHz < f < 1.5MHz (PLL BW of 5-16MHz or 8-5MHz, CDR = 5MHz)		0.01	0.10		ps (rms)	1,2,4,5
		PCIe Gen 2 High Band 1.5MHz < f < Nyquist (50MHz) (PLL BW of 5-16MHz or 8-5MHz, CDR = 5MHz)		0.16	0.21		ps (rms)	1,2,4,5
	$t_{jphPCIeG3-CC}$	PCIe Gen 3 (PLL BW of 2-4MHz or 2-5MHz, CDR = 10MHz)		0.07	0.10		ps (rms)	1,2,4,5
	$t_{jphPCIeG4-CC}$	PCIe Gen 4 (PLL BW of 2-4MHz or 2-5MHz, CDR = 10MHz)		0.07	0.10		ps (rms)	1,2,4,5

[1] Applies to all outputs.

[2] Based on PCIe Base Specification Rev4.0 version 1.0. See http://www.pcisig.com for latest specifications.

[3] Sample size of at least 100K cycles. This figure extrapolates to 108ps pk-pk at 1M cycles for a BER of 1^{-12}.

[4] For RMS values additive jitter is calculated by solving the following equation for b [*a^2+b^2=c^2*] where "a" is rms input jitter and "c" is rms total jitter.

[5] Driven by 9FGL0841 or equivalent.

Electrical Characteristics–Filtered Phase Jitter Parameters - PCIe Separate Reference Independent Spread (SRIS) Architectures[5]

T_{AMB} = over the specified operating range. Supply Voltages per normal operation Conditions, See Test Loads for Loading Conditions

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Industry Limit	Units	Notes
Additive Phase Jitter	$t_{jphPCIeG2-SRIS}$	PCIe Gen 2 (PLL BW of 16MHz , CDR = 5MHz)		0.21	0.26	n/a	ps (rms)	1,2,4
	$t_{jphPCIeG3-SRIS}$	PCIe Gen 3 (PLL BW of 2-4MHz or 2-5MHz, CDR = 10MHz)		0.06	0.11		ps (rms)	1,2,4

[1] Applies to all outputs.

[2] Based on PCIe Base Specification Rev3.1a. These filters are different than Common Clock filters. See http://www.pcisig.com for latest

[3] Sample size of at least 100K cycles. This figure extrapolates to 108ps pk-pk at 1M cycles for a BER of 1^{-12}.

[4] For RMS values, additive jitter is calculated by solving the following equation for b [*a^2+b^2=c^2*] where "a" is rms input jitter and "c" is rms total jitter.

[5] As of PCIe Base Specification Rev4.0 v1.0, SRIS is not currently defined for Gen1 or Gen4.

Electrical Characteristics– Unfiltered Phase Jitter Parameters

$T_A = T_{AMB}$, Supply Voltages per normal operation Conditions, See Test Loads for Loading Conditions

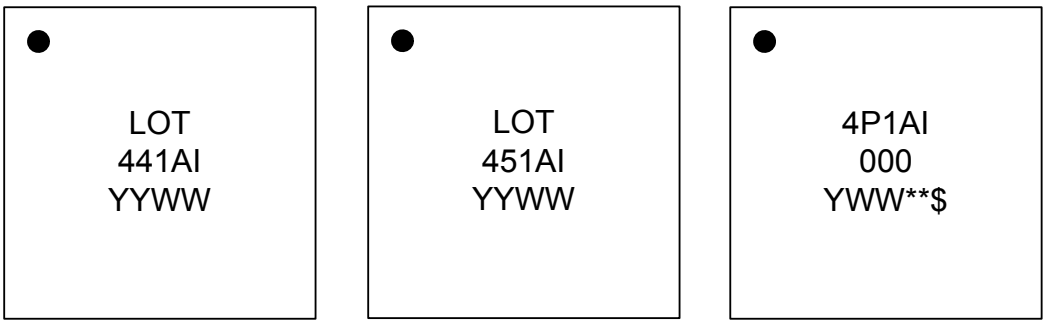
Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Industry Limit	Units	Notes
Additive Phase Jitter, Fanout Mode	$t_{jph156M}$	156.25MHz, 1.5MHz to 10MHz, -20dB/decade rollover < 1.5MHz, -40db/decade rolloff > 10MHz		114		n/a	fs (rms)	1,2,3
	$t_{jph156M12k-20}$	156.25MHz, 12kHz to 20MHz, -20dB/decade rollover <12kHz, -40db/decade rolloff > 20MHz		285			fs (rms)	1,2,3

[1] Guaranteed by design and characterization, not 100% tested in production.

[2] Driven by Rhode & Schwartz SMA100.

[3] For RMS values additive jitter is calculated by solving the following equation for b [a^2+b^2=c^2] where "a" is rms input jitter and "c" is rms total jitter.

Marking Diagrams



Notes:
1. “LOT” is the lot sequence number.
2. “YYWW” or “YWW” is the digits of the year and week that the part was assembled.
3. “I” denotes industrial temperature range device.
4. “P” denotes factory programmable defaults.
5. “**” denotes the lot sequence.
6. “$” denotes the mark code.

Thermal Characteristics

Parameter	Symbol	Conditions	PKG	Typical VALUE	Units	Notes
Thermal Resistance	θ_{JC}	Junction to Case	NLG24	42	°C/W	1
	θ_{Jb}	Junction to Base		2.4	°C/W	1
	θ_{JA0}	Junction to Air, still air		39	°C/W	1
	θ_{JA1}	Junction to Air, 1 m/s air flow		33	°C/W	1
	θ_{JA3}	Junction to Air, 3 m/s air flow		28	°C/W	1
	θ_{JA5}	Junction to Air, 5 m/s air flow		27	°C/W	1

[1] EPAD soldered to board.

Package Outline Drawings

The package outline drawings are appended at the end of this document and are accessible from the link below. The package information is the most current data available.

www.idt.com/document/psc/nlnlg24p1-package-outline-40-x-40-mm-body-05-mm-pitch-qfn-epad-size-245-x-245-mm

Ordering Information

Part / Order Number	Notes	ShippingPackaging	Package	Temperature
9DML0441AKILF	100Ω	Trays	24-VFQFPN	-40 to +85° C
9DML0441AKILFT		Tape and Reel	24-VFQFPN	-40 to +85° C
9DML0451AKILF	85Ω	Trays	24-VFQFPN	-40 to +85° C
9DML0451AKILFT		Tape and Reel	24-VFQFPN	-40 to +85° C
9DML04P1AxxxKILF	Factory configurable. Contact IDT for addtional information.	Trays	24-VFQFPN	-40 to +85° C
9DML04P1AxxxKILFT		Tape and Reel	24-VFQFPN	-40 to +85° C

“LF” suffix to the part number are the Pb-Free configuration and are RoHS compliant.

“A” is the device revision designator (will not correlate with the datasheet revision).

“xxx” is a unique factory assigned number to identify a particular default configuration.

Revision History

Issue Date	Description	Page #
8/27/2018	1. Minor updates to electrical tables. 2. Updated front page text. 3. Updated block diagram.	Various
6/6/2016	1. Updated leakage current spec for inputs with pull/up/down to +/-50µA. 2. Updated electrical tables with characterization data. 3. Update Front page text. 4. Updated ordering information. 5. Move to Final.	Various

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